











SN74LVC1T45

SCES515K - DECEMBER 2003-REVISED DECEMBER 2014

SN74LVC1T45 Single-Bit Dual-Supply Bus Transceiver With Configurable Voltage **Translation and 3-State Outputs**

Features

- Available in the Texas Instruments NanoFree™ Package
- Fully Configurable Dual-Rail Design Allows Each Port to Operate Over the Full 1.65-V to 5.5-V Power-Supply Range
- V_{CC} Isolation Feature If Either V_{CC} Input Is at GND, Both Ports Are in the High-Impedance State
- DIR Input Circuit Referenced to V_{CCA}
- Low Power Consumption, 4-µA Max I_{CC}
- ±24-mA Output Drive at 3.3 V
- I_{off} Supports Partial-Power-Down Mode Operation
- Max Data Rates
 - 420 Mbps (3.3-V to 5-V Translation)
 - 210 Mbps (Translate to 3.3 V)
 - 140 Mbps (Translate to 2.5 V)
 - 75 Mbps (Translate to 1.8 V)
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)

Applications

- Personal Electronic
- Industrial
- Enterprise
- Telecom

3 Description

This single-bit noninverting bus transceiver uses two separate configurable power-supply rails. The A port is designed to track $V_{\text{CCA}}.\ V_{\text{CCA}}$ accepts any supply voltage from 1.65 V to 5.5 V. The B port is designed to track $V_{\text{CCB}}.\ V_{\text{CCB}}$ accepts any supply voltage from 1.65 V to 5.5 V. This allows for universal low-voltage bidirectional translation between any of the 1.8-V, 2.5-V, 3.3-V, and 5-V voltage nodes.

The SN74LVC1T45 is designed for asynchronous communication between two data buses. The logic levels of the direction-control (DIR) input activate either the B-port outputs or the A-port outputs. The device transmits data from the A bus to the B bus when the B-port outputs are activated and from the B bus to the A bus when the A-port outputs are activated. The input circuitry on both A and B ports always is active and must have a logic HIGH or LOW level applied to prevent excess I_{CC} and I_{CCZ}.

Device Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE (NOM)
		2.90 mm × 1.60 mm
SN74LVC1T45	SOT (6)	2.00 mm × 1.25 mm
SN/4LVC1145		1.60 mm x 1.20 mm
	DSBGA (6)	1.39 mm × 0.90 mm

(1) For all available packages, see the orderable addendum at the end of the datasheet.

Functional Block Diagram

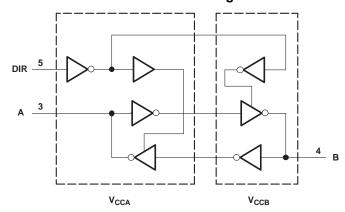




Table of Contents

1	Features 1	8	Parameter Measurement Information	1 1
2	Applications 1	9	Detailed Description	12
3	Description 1		9.1 Overview	12
4	Revision History2		9.2 Functional Block Diagram	12
5	Description (Continued)		9.3 Feature Description	12
6	Pin Configuration and Functions		9.4 Device Functional Modes	12
7	Specifications4	10	Applications and Implementation	13
′			10.1 Application Information	
	7.1 Absolute Maximum Ratings		10.2 Typical Application	
	7.3 Recommended Operating Conditions	11	Power Supply Recommendations	
	7.4 Thermal Information	12		
	7.5 Electrical Characteristics 6		12.1 Layout Guidelines	
			12.2 Layout Example	
	January Cook	13		
	J. J	13	13.1 Trademarks	
	3		13.2 Electrostatic Discharge Caution	
	7.9 Switching Characteristics (V _{CCA} = 5 V ±0.5 V) 8		13.3 Glossary	
	7.10 Operating Characteristics	4.4		17
	7.11 Typical Characteristics 9	14	Mechanical, Packaging, and Orderable Information	17
				17

4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision J (December 2013) to Revision K

Page

Changes from Revision I (December 2011) to Revision J

Page

- Updated document to new TI data sheet format no specification changes.
 Removed ordering information.
- Added ESD warning.



5 Description (Continued)

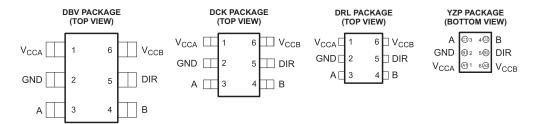
The SN74LVC1T45 is designed so that the DIR input is powered by V_{CCA}.

This device is fully specified for partial-power-down applications using I_{off} . The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

The V_{CC} isolation feature ensures that if either V_{CC} input is at GND, then both ports are in the high-impedance state.

NanoFree package technology is a major breakthrough in IC packaging concepts, using the die as the package.

6 Pin Configuration and Functions



See mechanical drawings for dimensions

Pin Functions

P	IN	1/0	DESCRIPTION					
NAME	NO.	I/O	DESCRIPTION					
V_{CCA}	1	р	SYSTEM-1 supply voltage (1.65 V to 5.5 V)					
GND	2	G	Device GND					
Α	3	I/O	Output level depends on V _{CC1} voltage.					
В	4	I/O	Input threshold value depends on V _{CC2} voltage.					
DIR	5	I	GND (low level) determines B-port to A-port direction.					
V _{CCB}	6	Р	SYSTEM-2 supply voltage (1.65 V to 5.5 V)					



7 Specifications

7.1 Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V _{CCA} V _{CCB}	Supply voltage		-0.5	6.5	V
VI	Input voltage ⁽²⁾	-0.5	6.5	V	
Vo	Voltage range applied to any output in the high-impeda	-0.5	6.5	V	
.,	Voltage range applied to any output in the high or low	A port	-0.5	V _{CCA} + 0.5	
Vo	state ⁽²⁾⁽³⁾	B port	-0.5	V _{CCB} + 0.5	V
I _{IK}	Input clamp current	V ₁ < 0		– 50	mA
I _{OK}	Output clamp current	V _O < 0		– 50	mA
Io	Continuous output current	•		±50	mA
	Continuous current through V _{CC} or GND			±100	mA
T _{stg}	Storage temperature, T _{stg}		-65	150	°C

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

7.2 ESD Ratings

			VALUE	UNIT
		Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 (1)	±2000	
V _(ESD)	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±1000	V
		Machine Model	±200	

⁽¹⁾ JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

7.3 Recommended Operating Conditions

See (1)(2)(3)

			V _{CCI}	V _{cco}	MIN	MAX	UNIT
V_{CCA}	Committee				1.65	5.5	\ /
V _{CCB}	Supply voltage				1.65	5.5	V
			1.65 o 1.95 V		V _{CCI} × 0.65		
.,	High-level	Data inputs ⁽⁴⁾	2.3 to 2.7 V		1.7		V
V _{IH}	input voltage	Data inputs 17	3 to 3.6 V		2		V
			4.5 to 5.5 V		$V_{CCI} \times 0.7$		
			1.65 o 1.95 V			$V_{CCI} \times 0.35$	
.,	Low-level	Data inputs ⁽⁴⁾	2.3 to 2.7 V			0.7	V
V _{IL}	input voltage	Data inputs 17	3 to 3.6 V			0.8	V
			4.5 to 5.5 V			$V_{CCI} \times 0.3$	

(4) For V_{CCI} values not specified in the data sheet, V_{IH} min = $V_{CCI} \times 0.7$ V, V_{IL} max = $V_{CCI} \times 0.3$ V.

4 Submit Documentation Feedback

Copyright © 2003–2014, Texas Instruments Incorporated

⁽³⁾ The value of V_{CC} is provided in the recommended operating conditions table.

⁽²⁾ JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

⁽¹⁾ V_{CCI} is the V_{CC} associated with the input port.

⁽²⁾ V_{CCO} is the V_{CC} associated with the output port.

⁽³⁾ All unused data inputs of the device must be held at V_{CCI} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



Recommended Operating Conditions (continued)

See (1)(2)(3)

			V _{cci}	V _{cco}	MIN	MAX	UNIT	
			1.65 to 1.95 V		V _{CCA} × 0.65			
.,	High-level	DIR	2.3 to 2.7 V		1.7		V	
V_{IH}	input voltage	(referenced to V _{CCA}) ⁽⁵⁾	3 to 3.6 V		2		V	
			4.5 to 5.5 V		$V_{CCA} \times 0.7$			
			1.65 to 1.95 V			$V_{CCA} \times 0.35$		
\	Low-level	DIR	2.3 to 2.7 V			0.7	V	
V_{IL}	input voltage	(referenced to V _{CCA}) ⁽⁵⁾	3 to 3.6 V			0.8	V	
			4.5 to 5.5 V			$V_{CCA} \times 0.3$		
VI	Input voltage				0	5.5	V	
Vo	Output voltage				0	V _{cco}	V	
				1.65 to 1.95 V		-4		
	High lovel output o	urront		2.3 to 2.7 V		-8	mA	
I _{OH}	nign-ievei output d	High-level output current		3 to 3.6 V		-24	ША	
				4.5 to 5.5 V		-32		
				1.65 to 1.95 V		4		
	Low lovel output o	umant		2.3 to 2.7 V		8	mA	
l _{OL}	Low-level output co	urrent		3 to 3.6 V		24	MA	
				4.5 to 5.5 V		32		
			1.65 to 1.95 V			20		
		Data inputa	2.3 to 2.7 V			20		
Δt/Δν	Input transition rise or fall rate	Data inputs	3 to 3.6 V			10	ns/V	
			4.5 to 5.5 V			5		
		Control inputs	1.65 to 5.5 V			5	1	
T _A	Operating free-air	temperature			-40	85	°C	

⁽⁵⁾ For V_{CCI} values not specified in the data sheet, V_{IH} min = $V_{CCA} \times 0.7$ V, V_{IL} max = $V_{CCA} \times 0.3$ V.

7.4 Thermal Information

			SN74L	VC1T45				
	THERMAL METRIC ⁽¹⁾	DBV	DCK	DRL	YZP	UNIT		
			6 PINS					
$R_{\theta JA}$	Junction-to-ambient thermal resistance	200.1	286.8	223.7	131.0			
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	144.5	93.9	88.7	1.3			
$R_{\theta JB}$	Junction-to-board thermal resistance	45.7	95.5	58.4	22.6	°C/W		
ΨЈТ	Junction-to-top characterization parameter	36.2	1.9	5.9	5.2	C/VV		
ΨЈВ	Junction-to-board characterization parameter	25.3	94.7	58.1	22.6			
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A	N/A	N/A	N/A			

⁽¹⁾ For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.



7.5 Electrical Characteristics⁽¹⁾⁽²⁾

over recommended operating free-air temperature range (unless otherwise noted)

DADA	METER	TEST CONDI	TIONS	V	V	T,	_λ = 25 °C	;	-40 to 8	85°C	LINUT
PARA	METER	TEST CONDIT	IIONS	V _{CCA}	V _{CCB}	MIN	TYP	MAX	MIN	MAX	UNIT
		I _{OH} = -100 μA		1.65 to 4.5 V	1.65 to 4.5 V				V _{CCO} - 0.1		
		$I_{OH} = -4 \text{ mA}$		1.65 V	1.65 V				1.2		
V_{OH}		$I_{OH} = -8 \text{ mA}$	$V_I = V_{IH}$	2.3 V	2.3 V				1.9		V
		$I_{OH} = -24 \text{ mA}$		3 V	3 V				2.4		
		$I_{OH} = -32 \text{ mA}$		4.5 V	4.5 V				3.8		
		I _{OL} = 100 μA		1.65 to 4.5 V	1.65 to 4.5 V					0.1	
		$I_{OL} = 4 \text{ mA}$		1.65 V	1.65 V					0.45	
V_{OL}		$I_{OL} = 8 \text{ mA}$	$V_I = V_{IL}$	2.3 V	2.3 V					0.3	V
		$I_{OL} = 24 \text{ mA}$		3 V	3 V					0.55	
		$I_{OL} = 32 \text{ mA}$		4.5 V	4.5 V					0.55	
I	DIR	$V_I = V_{CCA}$ or GND	·	1.65 to 5.5 V	1.65 to 5.5 V			±1		±2	μΑ
	A port	V 27.V 0 to 5.5	\ /	0 V	0 to 5.5 V			±1		±2	
I _{off}	B port	V_{I} or $V_{O} = 0$ to 5.5	V	0 to 5.5 V	0 V			±1		±2	μΑ
I _{OZ}	A or B port	V _O = V _{CCO} or GND	ı	1.65 to 5.5 V	1.65 to 5.5 V			±1		±2	μΑ
				1.65 to 5.5 V	1.65 to 5.5 V					3	
I_{CCA}		$V_I = V_{CCI}$ or GND,	$I_O = 0$	5.5 V	0 V					2	μΑ
				0 V	5.5 V					-2	
				1.65 to 5.5 V	1.65 to 5.5 V					3	
I_{CCB}		$V_I = V_{CCI}$ or GND,	$I_O = 0$	5.5 V	0 V					-2	μΑ
				0 V	5.5 V					2	
I _{CCA} + I (see Ta		$V_I = V_{CCI}$ or GND,	I _O = 0	1.65 to 5.5 V	1.65 to 5.5 V					4	μΑ
	A port	A port at V _{CCA} – 0.0 DIR at V _{CCA} , B por	6 V, t = open							50	
ΔI _{CCA}	DIR	DIR at V _{CCA} – 0.6 \ B port = open, A port at V _{CCA} or G		3 to 5.5 V	3 to 5.5 V					50	μΑ
ΔI _{CCB}	B port	B port at V _{CCB} – 0.6 DIR at GND, A port = open	6 V,	3 to 5.5 V	3 to 5.5 V					50	μΑ
C_{i}	DIR	$V_I = V_{CCA}$ or GND		3.3 V	3.3 V		2.5				pF
C_{io}	A or B port	$V_O = V_{CCA/B}$ or GN	D	3.3 V	3.3 V		6				pF

 $[\]begin{array}{ll} \hbox{(1)} & V_{CCO} \mbox{ is the } V_{CC} \mbox{ associated with the output port.} \\ \hbox{(2)} & V_{CCI} \mbox{ is the } V_{CC} \mbox{ associated with the input port.} \\ \end{array}$

Submit Documentation Feedback

Copyright © 2003–2014, Texas Instruments Incorporated



7.6 Switching Characteristics ($V_{CCA} = 1.8 \text{ V} \pm 0.15 \text{ V}$)

over recommended operating free-air temperature range, $V_{CCA} = 1.8 \text{ V} \pm 0.15 \text{ V}$ (see Figure 9)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CCB} = 1.8 V ±0.15 V		V _{CCB} = 2.5 V ±0.2 V		V _{CCB} = 3.3 V ±0.3 V		V _{CCB} = 5 V ±0.5 V		UNIT	
	(INPOT)	(OUTPUT)	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX		
t _{PLH}	А	В	3	17.7	2.2	10.3	1.7	8.3	1.4	7.2	20	
t _{PHL}	Α	ь	2.8	14.3	2.2	8.5	1.8	7.1	1.7	7	ns	
t _{PLH}	В	А	3	17.7	2.3	16	2.1	15.5	1.9	15.1		
t _{PHL}	В	A	2.8	14.3	2.1	12.9	2	12.6	1.8	12.2	ns	
t _{PHZ}	DIR	^	5.2	19.4	4.8	18.5	4.7	18.4	5.1	17.1	20	
t _{PLZ}	DIK	Α	2.3	10.5	2.1	10.5	2.4	10.7	3.1	10.9	ns	
t _{PHZ}	DIR	В	7.4	21.9	4.9	11.5	4.6	10.3	2.8	8.2		
t _{PLZ}	אוט	Ь	4.2	16	3.7	9.2	3.3	8.4	2.4	6.4	ns	
t _{PZH} ⁽¹⁾	DID	А		33.7		25.2		23.9		21.5		
t _{PZL} ⁽¹⁾	DIR	A		36.2		24.4		22.9		20.4	ns	
t _{PZH} ⁽¹⁾	DIR	DID	DIR B		28.2		20.8		19		18.1	
t _{PZL} ⁽¹⁾		В		33.7		27		25.5		24.1	ns	

⁽¹⁾ The enable time is a calculated value, derived using the formula shown in the Enable Times section.

7.7 Switching Characteristics ($V_{CCA} = 2.5 \text{ V} \pm 0.2 \text{ V}$)

over recommended operating free-air temperature range, $V_{CCA} = 2.5 \text{ V} \pm 0.2 \text{ V}$ (see Figure 9)

PARAMETER			TO +0.15 V		V _{CCB} = 2.5 V ±0.2 V		V _{CCB} = 3.3 V ±0.3 V		V _{CCB} = 5 V ±0.5 V		UNIT								
	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX									
t _{PLH}	Α	В	2.3	16	1.5	8.5	1.3	6.4	1.1	5.1	20								
t _{PHL}	A	ь	2.1	12.9	1.4	7.5	1.3	5.4	0.9	4.6	ns								
t _{PLH}	В	А	2.2	10.3	1.5	8.5	1.4	8	1	7.5									
t _{PHL}	Б	A	2.2	8.5	1.4	7.5	1.3	7	0.9	6.2	ns								
t _{PHZ}	DIR	А	3	8.1	3.1	8.1	2.8	8.1	3.2	8.1	20								
t _{PLZ}	DIK	A	1.3	5.9	1.3	5.9	1.3	5.9	1	5.8	ns								
t _{PHZ}	DIR	В	6.5	23.7	4.1	11.4	3.9	10.2	2.4	7.1	ns								
t _{PLZ}	DIK	ь	3.9	18.9	3.2	9.6	2.8	8.4	1.8	5.3	115								
t _{PZH} ⁽¹⁾	DID	^		29.2		18.1		16.4		12.8									
t _{PZL} ⁽¹⁾	DIR	DIR A		32.2		18.9		17.2		13.3	ns								
t _{PZH} ⁽¹⁾	DIP	DID	DID	NIP	DID	DIB	DIB	DIR	DIR	DIR B		21.9		14.4		12.3		10.9	20
t _{PZL} ⁽¹⁾	אוט	В		21		15.6		13.5		12.7	ns								

⁽¹⁾ The enable time is a calculated value, derived using the formula shown in the *Enable Times* section.



7.8 Switching Characteristics ($V_{CCA} = 3.3 \text{ V} \pm 0.3 \text{ V}$)

over recommended operating free-air temperature range, V_{CCA} = 3.3 V \pm 0.3 V (see Figure 9)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CCB} = 1.8 V ±0.15 V		V _{CCB} = 2.5 V ±0.2 V		V _{CCB} = 3.3 V ±0.3 V		V _{CCB} = 5 V ±0.5 V		UNIT	
	(INPUT)	(001701)	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX		
t _{PLH}	Α	В	2.1	15.5	1.4	8	0.7	5.8	0.7	4.4	20	
t _{PHL}	А	ь	2	12.6	1.3	7	0.8	5	0.7	4	ns	
t _{PLH}	В	۸	1.7	8.3	1.3	6.4	0.7	5.8	0.6	5.4		
t _{PHL}	В	Α	1.8	7.1	1.3	5.4	0.8	5	0.7	4.5	ns	
t _{PHZ}	DIR	۸	2.9	7.3	3	7.3	2.8	7.3	3.4	7.3	20	
t _{PLZ}	DIK	A	1.8	5.6	1.6	5.6	2.2	5.7	2.2	5.7	ns	
t _{PHZ}	DID	В	5.4	20.5	3.9	10.1	2.9	8.8	2.4	6.8		
t _{PLZ}	DIR	Ь	3.3	14.5	2.9	7.8	2.4	7.1	1.7	4.9	ns	
t _{PZH} ⁽¹⁾	DID	۸		22.8		14.2		12.9		10.3		
t _{PZL} ⁽¹⁾	DIR	Α		27.6		15.5		13.8		11.3	ns	
t _{PZH} ⁽¹⁾	DIR	DID	В		21.1		13.6		11.5		10.1	
t _{PZL} ⁽¹⁾	DIK	Б		19.9		14.3		12.3		11.3	ns	

⁽¹⁾ The enable time is a calculated value, derived using the formula shown in the Enable Times section.

7.9 Switching Characteristics ($V_{CCA} = 5 \text{ V} \pm 0.5 \text{ V}$)

over recommended operating free-air temperature range, $V_{CCA} = 5 \text{ V} \pm 0.5 \text{ V}$ (see Figure 9)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CCB} = 1 ±0.15	1.8 V V	V _{CCB} = ±0.2	2.5 V V	V _{CCB} = 3 ±0.3	3.3 V V	V _{CCB} = ±0.5	5 V V	UNIT
	(INPOT)	(001701)	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t _{PLH}	А	В	1.9	15.1	1	7.5	0.6	5.4	0.5	3.9	no
t _{PHL}	A	ь	1.8	12.2	0.9	6.2	0.7	4.5	0.5	3.5	ns
t _{PLH}	В	А	1.4	7.2	1	5.1	0.7	4.4	0.5	3.9	20
t _{PHL}	Ь	A	1.7	7	0.9	4.6	0.7	4	0.5	3.5	ns
t _{PHZ}	DIR	А	2.1	5.4	2.2	5.4	2.2	5.5	2.2	5.4	ns
t _{PLZ}	DIK		0.9	3.8	1	3.8	1	3.7	0.9	3.7	115
t _{PHZ}	DIR	В	4.8	20.2	2.5	9.8	1	8.5	2.5	6.5	no
t _{PLZ}	DIK	ь	4.2	14.8	2.5	7.4	2.5	7	1.6	4.5	ns
t _{PZH} ⁽¹⁾	DIR	^		22		12.5		11.4		8.4	no
t _{PZL} ⁽¹⁾	DIK	Α		27.2		14.4		12.5		10	ns
t _{PZH} ⁽¹⁾	DID	В		18.9		11.3		9.1		7.6	20
t _{PZL} ⁽¹⁾	DIR	В		17.6		11.6		10		8.6	ns

⁽¹⁾ The enable time is a calculated value, derived using the formula shown in the *Enable Times* section.

7.10 Operating Characteristics

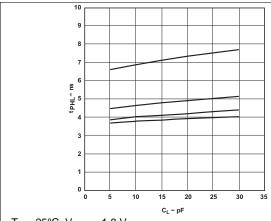
 $T_A = 25$ °C

	PARAMETER	TEST CONDITIONS	V _{CCA} = V _{CCB} = 1.8 V	V _{CCA} = V _{CCB} = 2.5 V	V _{CCA} = V _{CCB} = 3.3 V	V _{CCA} = V _{CCB} = 5 V TYP	UNIT	
C _{pdA} ⁽¹⁾	A-port input, B-port output	$C_L = 0 pF$,	3	4	4	4	_	
	B-port input, A-port output	f = 10 MHz, t _r = t _f = 1 ns	18	19	20	21	pF	
(4)	A-port input, B-port output	$C_L = 0 pF$,	18	19	20	21		
C _{pdB} ⁽¹⁾	B-port input, A-port output	f = 10 MHz, t _r = t _f = 1 ns	3	4	4	4	pF	

(1) Power dissipation capacitance per transceiver

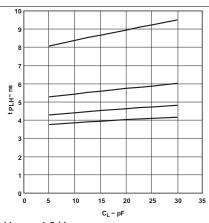


7.11 Typical Characteristics



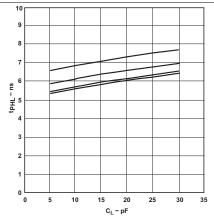
 $T_A = 25^{\circ}C, V_{CCA} = 1.8 \text{ V}$

Figure 1. Typical Propagation Delay (A to B) vs Load Capacitance



 $T_A = 25$ °C, $V_{CCA} = 1.8 \text{ V}$

Figure 2. Typical Propagation Delay (B to A) vs Load Capacitance



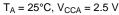
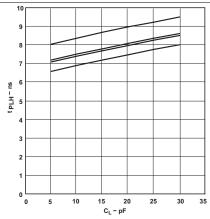


Figure 3. Typical Propagation Delay (A to B) vs Load Capacitance



 $T_A = 25$ °C, $V_{CCA} = 2.5 \text{ V}$

Figure 4. Typical Propagation Delay (B to A) vs Load Capacitance

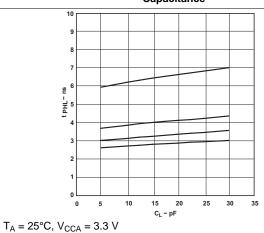
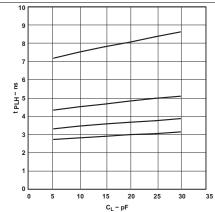


Figure 5. Typical Propagation Delay (A to B) vs Load Capacitance



 $T_A = 25$ °C, $V_{CCA} = 3.3 \text{ V}$

Figure 6. Typical Propagation Delay (B to A) vs Load Capacitance



Typical Characteristics (continued)

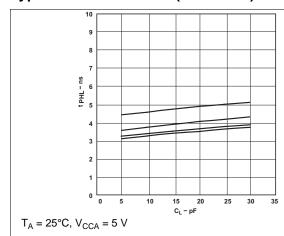
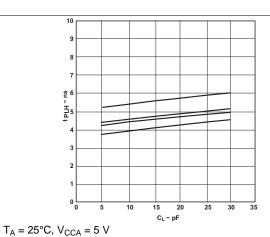


Figure 7. Typical Propagation Delay (A to B) vs Load Capacitance



-A =0 0, 100A 0 1

Figure 8. Typical Propagation Delay (B to A) vs Load Capacitance

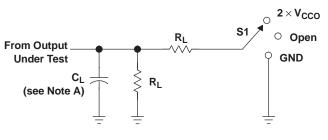
Submit Documentation Feedback

Copyright © 2003–2014, Texas Instruments Incorporated

 V_{CCA}



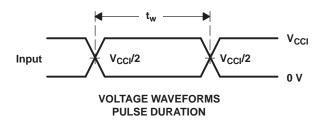
8 Parameter Measurement Information



TEST	S1
t _{pd}	Open
t _{PLZ} /t _{PZL}	$2\times\mathbf{V_{CCO}}$
t _{PHZ} /t _{PZH}	GND

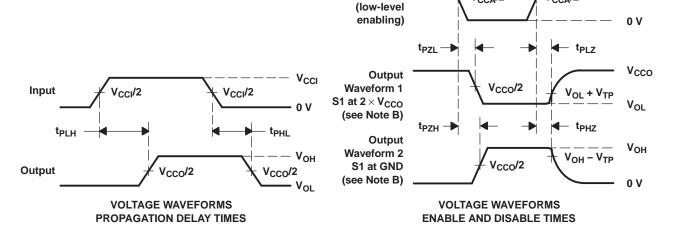
LOAD CIRCUIT

V _{CCO}	CL	R_{L}	V _{TP}
1.8 V ± 0.15 V	15 pF	2 k Ω	0.15 V
2.5 V \pm 0.2 V	15 pF	2 k Ω	0.15 V
3.3 V \pm 0.3 V	15 pF	2 k Ω	0.3 V
5 V ± 0.5 V	15 pF	2 k Ω	0.3 V



V_{CCA}/2

V_{CCA}/2



Output Control

- NOTES: A. C_L includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_0 = 50 \Omega$, $dv/dt \geq$ 1 V/ns.
 - D. The outputs are measured one at a time, with one transition per measurement.
 - E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
 - F. t_{PZL} and t_{PZH} are the same as t_{en}.
 - G. t_{PLH} and t_{PHL} are the same as t_{pd} .
 - H. V_{CCI} is the V_{CC} associated with the input port.
 - I. V_{CCO} is the V_{CC} associated with the output port.
 - J. All parameters and waveforms are not applicable to all devices.

Figure 9. Load Circuit and Voltage Waveforms

Submit Documentation Feedback



9 Detailed Description

9.1 Overview

The SN74LVC1T45 is single-bit, dual-supply, non-inverting voltage level translation. Pin A and that direction control pin (DIR) are supported by V_{CCA} and pin B is supported by V_{CCB} . The A port is able to accept I/O voltages ranging from 1.65 V to 5.5 V, while the B port can accept I/O voltages from 1.65 V to 5.5 V. The high on the DIR allows data transmissions from A to B and a low on the DIR allows data transmissions from B to A.

9.2 Functional Block Diagram

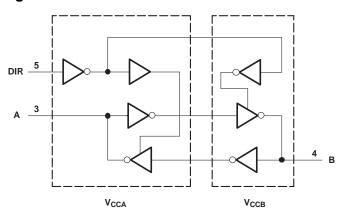


Figure 10. Logic Diagram (Positive Logic)

9.3 Feature Description

9.3.1 Fully Configurable Dual-Rail Design Allows Each Port to Operate Over the Full 1.65-V to 5.5-V Power-Supply Range

Both V_{CCA} and V_{CCB} can be supplied at any voltage between 1.65 V and 5.5 V, making the device suitable for translating between any of the voltage nodes (1.8-V, 2.5-V, 3.3-V and 5-V).

9.3.2 Support High Speed Translation

SN74LVC1T45 can support high data rate applications. The translated signal data rate can be up to 420 Mbps when the signal is translated from 3.3 V to 5 V.

9.3.3 I_{off} Supports Partial Power-Down Mode Operation

I_{off} will prevent backflow current by disabling I/O output circuits when device is in partial-power-down mode.

9.4 Device Functional Modes

Table 1. Function Table (1)

INPUT DIR	OPERATION
L	B data to A bus
Н	A data to B bus

(1) Input circuits of the data I/Os always are active.



10 Applications and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

10.1 Application Information

The SN74LVC1T45 device can be used in level-translation applications for interfacing devices or systems operating at different interface voltages with one another. The max data rate can be up to 420 Mbps when device translates signals from 3.3 V to 5 V.

10.2 Typical Application

10.2.1 Unidirectional Logic Level-Shifting Application

Figure 11 shows an example of the SN74LVC1T45 being used in a unidirectional logic level-shifting application.

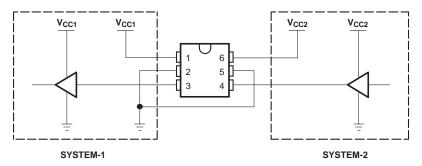


Figure 11. Unidirectional Logic Level-Shifting Application

10.2.1.1 Design Requirements

For this design example, use the parameters listed in Table 2.

Table 2. Design Parameters

DESIGN PARAMETER	EXAMPLE VALUE
Input voltage range	1.65 V to 5.5 V
Output voltage range	1.65 V to 5.5 V

10.2.1.2 Detailed Design Procedure

To begin the design process, determine the following:

- Input voltage range
 - Use the supply voltage of the device that is driving the SN74LVC1T45 device to determine the input voltage range. For a valid logic high the value must exceed the V_{IH} of the input port. For a valid logic low the value must be less than the V_{IL} of the input port.
- Output voltage range
 - Use the supply voltage of the device that the SN74LVC1T45 device is driving to determine the output voltage range.

10.2.1.3 Application Curve

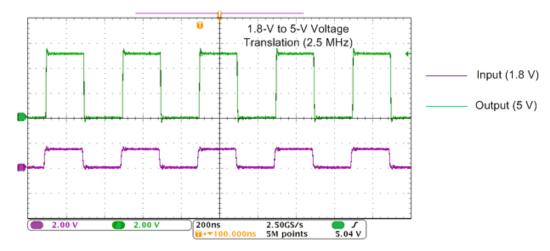


Figure 12. Translation Up (1.8 V to 5 V) at 2.5 MHz

10.2.2 Bidirectional Logic Level-Shifting Application

Figure 13 shows the SN74LVC1T45 being used in a bidirectional logic level-shifting application. Since the SN74LVC1T45 does not have an output-enable (OE) pin, the system designer should take precautions to avoid bus contention between SYSTEM-1 and SYSTEM-2 when changing directions.

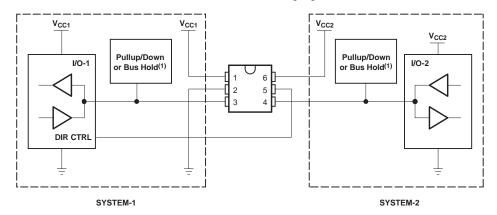


Figure 13. Bidirectional Logic Level-Shifting Application

10.2.2.1 Design Requirements

Please refer to Design Requirements.

10.2.2.2 Detailed Design Procedure

Table 3 shows data transmission from SYSTEM-1 to SYSTEM-2 and then from SYSTEM-2 to SYSTEM-1.

Table 3. SYSTEM-1 and SYSTEM-2 Data Transmission

STATE	DIR CTRL	I/O-1	I/O-2	DESCRIPTION
1	Н	Out	In	SYSTEM-1 data to SYSTEM-2
2	Н	Hi-Z	Hi-Z	SYSTEM-2 is getting ready to send data to SYSTEM-1. I/O-1 and I/O-2 are disabled. The busline state depends on pullup or pulldown. (1)
3	L	Hi-Z	Hi-Z	DIR bit is flipped. I/O-1 and I/O-2 still are disabled. The bus-line state depends on pullup or pulldown. (1)
4	L	Out	In	SYSTEM-2 data to SYSTEM-1

(1) SYSTEM-1 and SYSTEM-2 must use the same conditions, i.e., both pullup or both pulldown.

Submit Documentation Feedback



10.2.2.2.1 Enable Times

Calculate the enable times for the SN74LVC1T45 using the following formulas:

- t_{PZH} (DIR to A) = t_{PLZ} (DIR to B) + t_{PLH} (B to A)
- t_{PZL} (DIR to A) = t_{PHZ} (DIR to B) + t_{PHL} (B to A)
- t_{PZH} (DIR to B) = t_{PLZ} (DIR to A) + t_{PLH} (A to B)
- t_{PZL} (DIR to B) = t_{PHZ} (DIR to A) + t_{PHL} (A to B)

In a bidirectional application, these enable times provide the maximum delay from the time the DIR bit is switched until an output is expected. For example, if the SN74LVC1T45 initially is transmitting from A to B, then the DIR bit is switched; the B port of the device must be disabled before presenting it with an input. After the B port has been disabled, an input signal applied to it appears on the corresponding A port after the specified propagation delay.

10.2.2.3 Application Curve

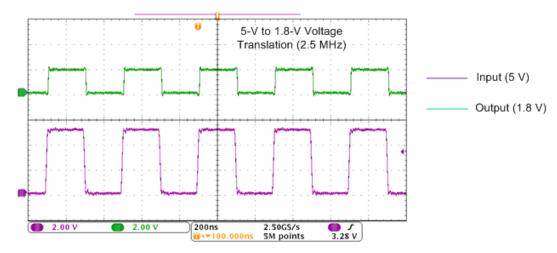


Figure 14. Translation Down (5V to 1.8 V) at 2.5 MHz



11 Power Supply Recommendations

The SN74LVC1T45 device uses two separate configurable power-supply rails, V_{CCA} and V_{CCB} . V_{CCA} accepts any supply voltage from 1.65 V to 5.5 V and V_{CCB} accepts any supply voltage from 1.65 V to 5.5 V. The A port and B port are designed to track V_{CCA} and V_{CCB} , respectively allowing for low-voltage bidirectional translation between any of the 1.8-V, 2.5-V, 3.3-V and 5-V voltage nodes.

12 Layout

12.1 Layout Guidelines

To ensure reliability of the device, the following common printed-circuit board layout guidelines are recommended:

- · Bypass capacitors should be used on power supplies.
- · Short trace lengths should be used to avoid excessive loading.
- Placing pads on the signal paths for loading capacitors or pullup resistors to help adjust rise and fall times of signals depends on the system requirements

12.2 Layout Example



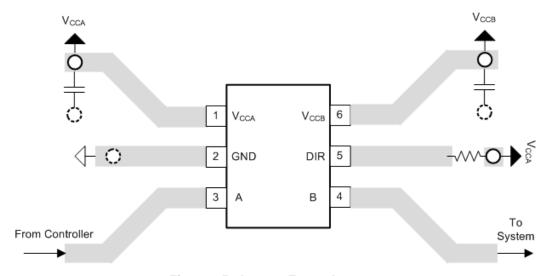


Figure 15. Layout Example

6 Submit Documentation Feedback

Copyright © 2003–2014, Texas Instruments Incorporated



13 Device and Documentation Support

13.1 Trademarks

NanoFree is a trademark of Texas Instruments.
All other trademarks are the property of their respective owners.

13.2 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

13.3 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.





21-Jul-2014

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish (6)	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
SN74LVC1T45DBVR	ACTIVE	SOT-23	DBV	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(CT15 ~ CT1F ~ CT1R)	Samples
SN74LVC1T45DBVRE4	ACTIVE	SOT-23	DBV	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(CT15 ~ CT1F ~ CT1R)	Samples
SN74LVC1T45DBVRG4	ACTIVE	SOT-23	DBV	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(CT15 ~ CT1F ~ CT1R)	Samples
SN74LVC1T45DBVT	ACTIVE	SOT-23	DBV	6	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(CT15 ~ CT1F ~ CT1R)	Samples
SN74LVC1T45DBVTG4	ACTIVE	SOT-23	DBV	6	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(CT15 ~ CT1F ~ CT1R)	Samples
SN74LVC1T45DCKR	ACTIVE	SC70	DCK	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(TA5 ~ TAF ~ TAR)	Samples
SN74LVC1T45DCKRE4	ACTIVE	SC70	DCK	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(TA5 ~ TAF ~ TAR)	Samples
SN74LVC1T45DCKRG4	ACTIVE	SC70	DCK	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(TA5 ~ TAF ~ TAR)	Samples
SN74LVC1T45DCKT	ACTIVE	SC70	DCK	6	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(TA5 ~ TAF ~ TAR)	Samples
SN74LVC1T45DCKTE4	ACTIVE	SC70	DCK	6	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(TA5 ~ TAF ~ TAR)	Samples
SN74LVC1T45DCKTG4	ACTIVE	SC70	DCK	6	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(TA5 ~ TAF ~ TAR)	Samples
SN74LVC1T45DPKR	ACTIVE	USON	DPK	6	5000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	TA7	Samples
SN74LVC1T45DRLR	ACTIVE	SOT	DRL	6	4000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(TA7 ~ TAR)	Samples
SN74LVC1T45DRLRG4	ACTIVE	SOT	DRL	6	4000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(TA7 ~ TAR)	Samples
SN74LVC1T45YZPR	ACTIVE	DSBGA	YZP	6	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-40 to 85	(TA2 ~ TA7 ~ TAN)	Samples

⁽¹⁾ The marketing status values are defined as follows: **ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PACKAGE OPTION ADDENDUM



21-.lul-2014

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF SN74LVC1T45:

Automotive: SN74LVC1T45-Q1

Enhanced Product: SN74LVC1T45-EP

NOTE: Qualified Version Definitions:

Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects



PACKAGE OPTION ADDENDUM

21-Jul-2014

• Enhanced Product - Supports Defense, Aerospace and Medical Applications

PACKAGE MATERIALS INFORMATION

www.ti.com 21-Jul-2014

TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LVC1T45DBVR	SOT-23	DBV	6	3000	180.0	8.4	3.23	3.17	1.37	4.0	8.0	Q3
SN74LVC1T45DBVR	SOT-23	DBV	6	3000	178.0	9.0	3.23	3.17	1.37	4.0	8.0	Q3
SN74LVC1T45DBVT	SOT-23	DBV	6	250	180.0	8.4	3.23	3.17	1.37	4.0	8.0	Q3
SN74LVC1T45DCKR	SC70	DCK	6	3000	178.0	9.0	2.4	2.5	1.2	4.0	8.0	Q3
SN74LVC1T45DCKR	SC70	DCK	6	3000	180.0	8.4	2.41	2.41	1.2	4.0	8.0	Q3
SN74LVC1T45DCKT	SC70	DCK	6	250	180.0	8.4	2.41	2.41	1.2	4.0	8.0	Q3
SN74LVC1T45DCKT	SC70	DCK	6	250	178.0	9.2	2.4	2.4	1.22	4.0	8.0	Q3
SN74LVC1T45DCKT	SC70	DCK	6	250	178.0	9.0	2.4	2.5	1.2	4.0	8.0	Q3
SN74LVC1T45DPKR	USON	DPK	6	5000	180.0	9.5	1.75	1.75	0.7	4.0	8.0	Q2
SN74LVC1T45DRLR	SOT	DRL	6	4000	180.0	9.5	1.78	1.78	0.69	4.0	8.0	Q3
SN74LVC1T45DRLR	SOT	DRL	6	4000	180.0	8.4	1.98	1.78	0.69	4.0	8.0	Q3
SN74LVC1T45YZPR	DSBGA	YZP	6	3000	178.0	9.2	1.02	1.52	0.63	4.0	8.0	Q1

PACKAGE MATERIALS INFORMATION

www.ti.com 21-Jul-2014



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74LVC1T45DBVR	SOT-23	DBV	6	3000	202.0	201.0	28.0
SN74LVC1T45DBVR	SOT-23	DBV	6	3000	180.0	180.0	18.0
SN74LVC1T45DBVT	SOT-23	DBV	6	250	202.0	201.0	28.0
SN74LVC1T45DCKR	SC70	DCK	6	3000	180.0	180.0	18.0
SN74LVC1T45DCKR	SC70	DCK	6	3000	202.0	201.0	28.0
SN74LVC1T45DCKT	SC70	DCK	6	250	202.0	201.0	28.0
SN74LVC1T45DCKT	SC70	DCK	6	250	180.0	180.0	18.0
SN74LVC1T45DCKT	SC70	DCK	6	250	180.0	180.0	18.0
SN74LVC1T45DPKR	USON	DPK	6	5000	184.0	184.0	19.0
SN74LVC1T45DRLR	SOT	DRL	6	4000	184.0	184.0	19.0
SN74LVC1T45DRLR	SOT	DRL	6	4000	202.0	201.0	28.0
SN74LVC1T45YZPR	DSBGA	YZP	6	3000	220.0	220.0	35.0

DBV (R-PDSO-G6)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
- D. Leads 1,2,3 may be wider than leads 4,5,6 for package orientation.
- Falls within JEDEC MO-178 Variation AB, except minimum lead width.



DBV (R-PDSO-G6)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.



DCK (R-PDSO-G6)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
- D. Falls within JEDEC MO-203 variation AB.



DCK (R-PDSO-G6)

PLASTIC SMALL OUTLINE



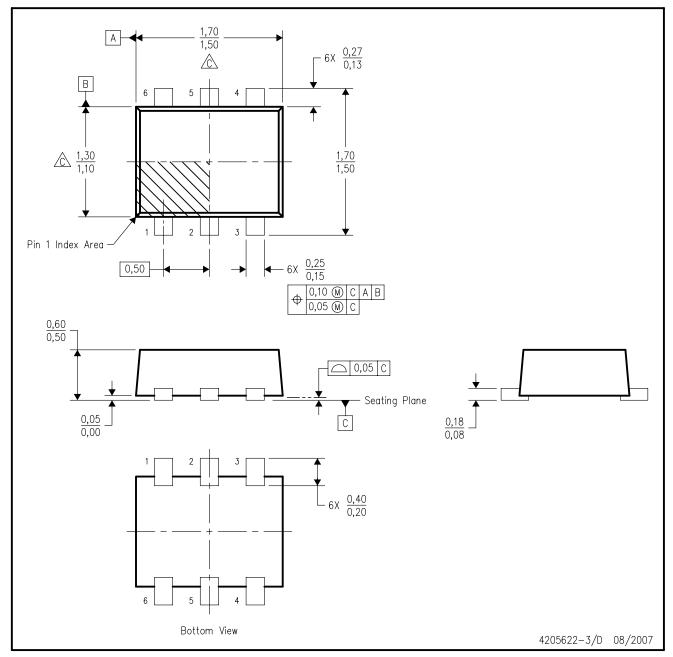
NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.



DRL (R-PDSO-N6)

PLASTIC SMALL OUTLINE



NOTES:

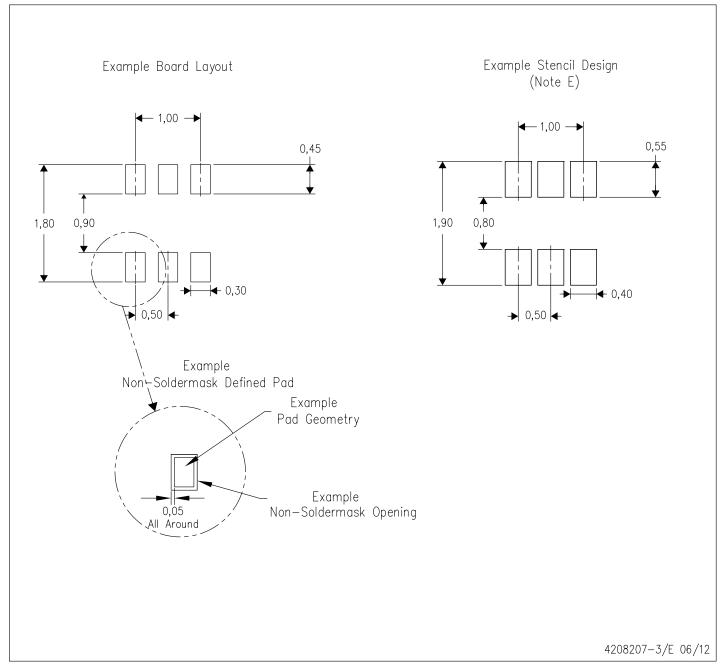
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- Body dimensions do not include mold flash, interlead flash, protrusions, or gate burrs.

 Mold flash, interlead flash, protrusions, or gate burrs shall not exceed 0,15 per end or side.
- D. JEDEC package registration is pending.



DRL (R-PDSO-N6)

PLASTIC SMALL OUTLINE



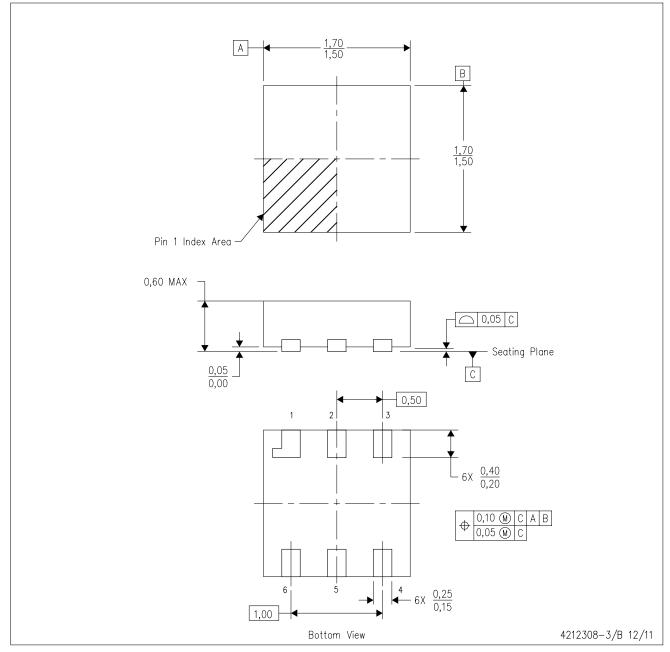
NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.
- E. Maximum stencil thickness 0,127 mm (5 mils). All linear dimensions are in millimeters.
- F. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- G. Side aperture dimensions over—print land for acceptable area ratio > 0.66. Customer may reduce side aperture dimensions if stencil manufacturing process allows for sufficient release at smaller opening.



DPK (S-PUSON-N6)

PLASTIC SMALL OUTLINE NO-LEAD

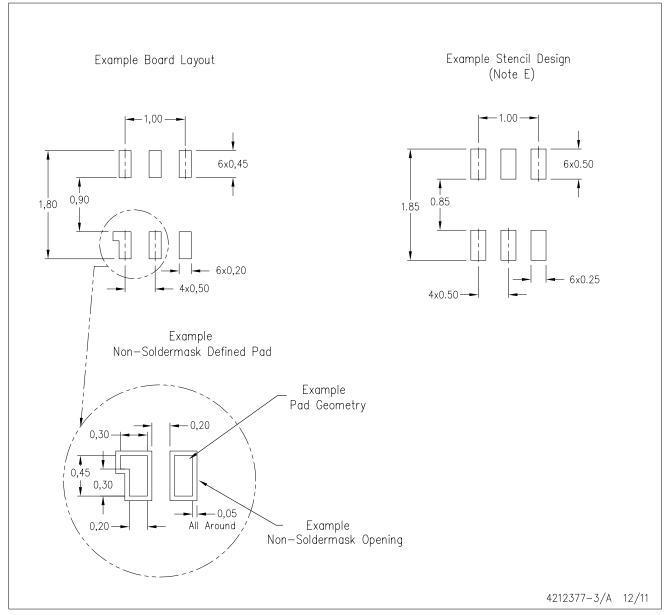


 A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 B. This drawing is subject to change without notice. NOTES:



DPK (S-PUSON-N6)

PLASTIC SMALL OUTLINE NO-LEAD

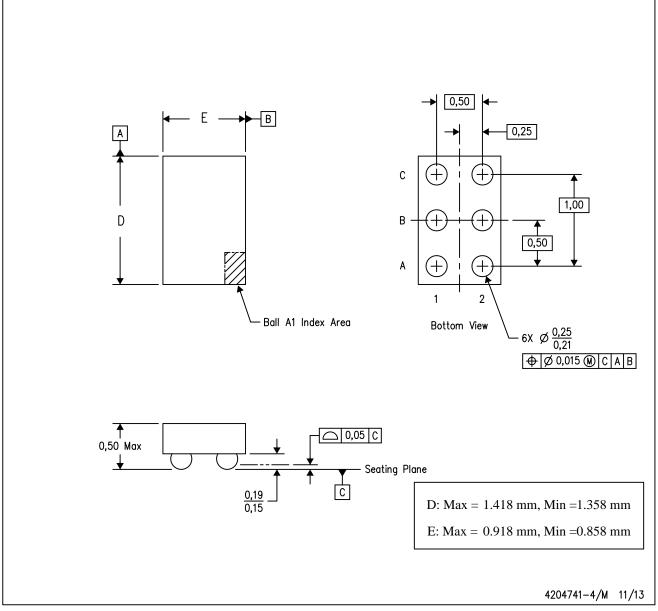


- NOTES: A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Publication IPC-7351 is recommended for alternate designs.
 - D. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.
 - E. Maximum stencil thickness 0,127 mm (5 mils). All linear dimensions are in millimeters.
 - F. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
 - G. Side aperture dimensions over-print land for acceptable area ratio > 0.66. Customer may reduce side aperture dimensions if stencil manufacturing process allows for sufficient release at smaller opening.



YZP (R-XBGA-N6)

DIE-SIZE BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. NanoFree \mathbf{M} package configuration.

NanoFree is a trademark of Texas Instruments.



IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46, latest issue, and to discontinue any product or service per JESD48, latest issue. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as "components") are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in TI's terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

TI assumes no liability for applications assistance or the design of Buyers' products. Buyers are responsible for their products and applications using TI components. To minimize the risks associated with Buyers' products and applications, Buyers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI components or services are used. Information published by TI regarding third-party products or services does not constitute a license to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of significant portions of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI components or services with statements different from or beyond the parameters stated by TI for that component or service voids all express and any implied warranties for the associated TI component or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyer acknowledges and agrees that it is solely responsible for compliance with all legal, regulatory and safety-related requirements concerning its products, and any use of TI components in its applications, notwithstanding any applications-related information or support that may be provided by TI. Buyer represents and agrees that it has all the necessary expertise to create and implement safeguards which anticipate dangerous consequences of failures, monitor failures and their consequences, lessen the likelihood of failures that might cause harm and take appropriate remedial actions. Buyer will fully indemnify TI and its representatives against any damages arising out of the use of any TI components in safety-critical applications.

In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI's goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have not been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components as meeting ISO/TS16949 requirements, mainly for automotive use. In any case of use of non-designated products, TI will not be responsible for any failure to meet ISO/TS16949.

Products Applications

logic.ti.com

Audio www.ti.com/audio Automotive and Transportation www.ti.com/automotive **Amplifiers** amplifier.ti.com Communications and Telecom www.ti.com/communications **Data Converters** dataconverter.ti.com Computers and Peripherals www.ti.com/computers **DLP® Products** www.dlp.com Consumer Electronics www.ti.com/consumer-apps DSP dsp.ti.com **Energy and Lighting** www.ti.com/energy Clocks and Timers www.ti.com/clocks Industrial www.ti.com/industrial Interface interface.ti.com Medical www.ti.com/medical Logic Security www.ti.com/security

Power Mgmt Space, Avionics and Defense www.ti.com/space-avionics-defense power.ti.com

Microcontrollers www.ti.com/video microcontroller.ti.com Video and Imaging

www.ti-rfid.com

OMAP Applications Processors TI E2E Community www.ti.com/omap e2e.ti.com

Wireless Connectivity www.ti.com/wirelessconnectivity